Search Notes							

Application/Control No.	Applicant(s)/Patent under Reexamination
09/929,995 Examiner	TERNULLO ET AL.
Sargon N. Nano	2157

SEARCHED				
Class	Subclass	Date	Examiner	
. 709	202, 203 217, 219 227, 229 231	11/3/2005	SN	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAst (see report)	11/3/2005	SN
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